

# UC1845A-SP QML Class V、放射線耐性強化の電流モード PWM コントローラ

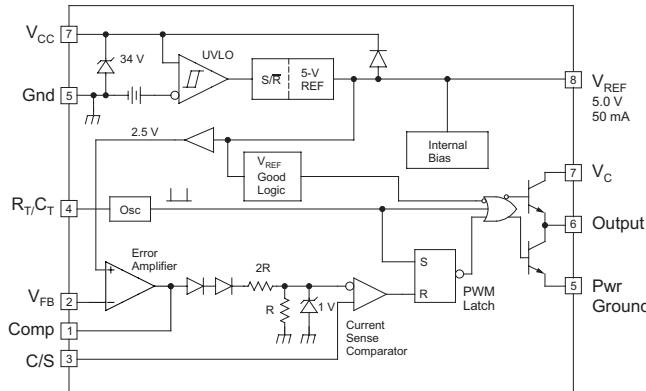
## 1 特長

- QML Class V (QMLV)認定済み、SMD 5962-86704
- 5962P8670411Vxx<sup>(1)</sup>
  - 吸收線量(TID) 30krad(Si)までの放射線耐性保証(RHA)
  - MIL-STD-883テスト手法1019.9段落3.13.3.bの定義に従い、1.5xのOver TestにおいてLDR (10 mrad(Si)/s)で45kradの機能および規定のPost-Radiationパラメータ制限に合格
  - 低線量率の感受性を示すが<sup>(2)</sup>、30kradの合計線量レベルにおいて、MIL-STD-883, TM1019で許容されるPre-Radiationの電気的制限範囲内を維持
- DC/DCコンバータアプリケーション用に最適化
- 低いスタートアップ電流(0.5mA未満)
- トリムされた発振器放電電流
- 自動的なフィードフォワード補償
- パルス単位の電流制限
- 拡張された負荷応答特性
- ヒステリシス付きの低電圧誤動作防止(UVLO)
- ダブル・パルス抑制
- 大電流トーテムポール出力
- 内部トリム付きのバンドギャップ参照
- 500kHzでの動作
- 低R<sub>O</sub>のエラー・アンプ

(1) TID放射線特性の強化は、RHAデバイス・タイプ11にのみ適用されます。

(2) 影響を受けるパラメータ参照出力電圧、V<sub>REF</sub>放射線ドリフト曲線([V<sub>REF</sub>放射線ドリフト曲線](#)を参照)

## 概略回路図



・ 軍事用温度範囲(-55°C~125°C)全体で認定済み

## 2 アプリケーション

- 放射線強化されたDC/DCコンバータ
- 衛星用バスおよびペイロード
- 宇宙への打ち上げ用ロケット
- 海底ケーブル
- 各種のトポロジをサポート
  - フライバック、フォワード、降圧、昇圧
  - 外部インターフェイス回路付きのプッシュプル、ハーフブリッジ、フルブリッジ

## 3 概要

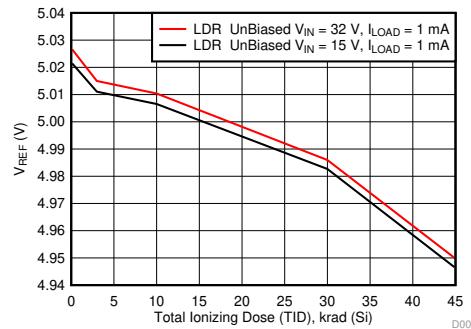
UC1845A-SPコントロールICは、UC184xファミリとピン互換の放射線強化版です。衛星や、過酷な環境で使用される他のアプリケーションに主に適しています。このデバイスは、電流モード・スイッチング・モード電源のコントロールに必要な特性を提供し、機能が拡張されています。スタートアップ電流は0.5mA未満に規定され、発振器放電は8.3mAにトリムされています。UVLO時には、5V以上のV<sub>CC</sub>について、出力ステージは1.2V未満で最低10mAをシンクします。

### 製品情報<sup>(1)</sup>

型番	パッケージ	本体サイズ(公称)
UC1845A-SP	CDIP/JG (8)	6.67mmx9.60mm
	LCCC/FK (20)	8.89mmx8.89mm
	CFP/HKU (10)	6.48mmx7.02mm

(1) 提供されているすべてのパッケージについては、巻末の注文情報を参照してください。

### V<sub>REF</sub>放射線ドリフト曲線



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## 4 改訂履歴

2015年5月発行のものから更新

Page

•	Changed the <i>Pin Configuration</i> images	4
•	Changed CT (pF) To: CT (μF) in <a href="#">Equation 1</a>	16

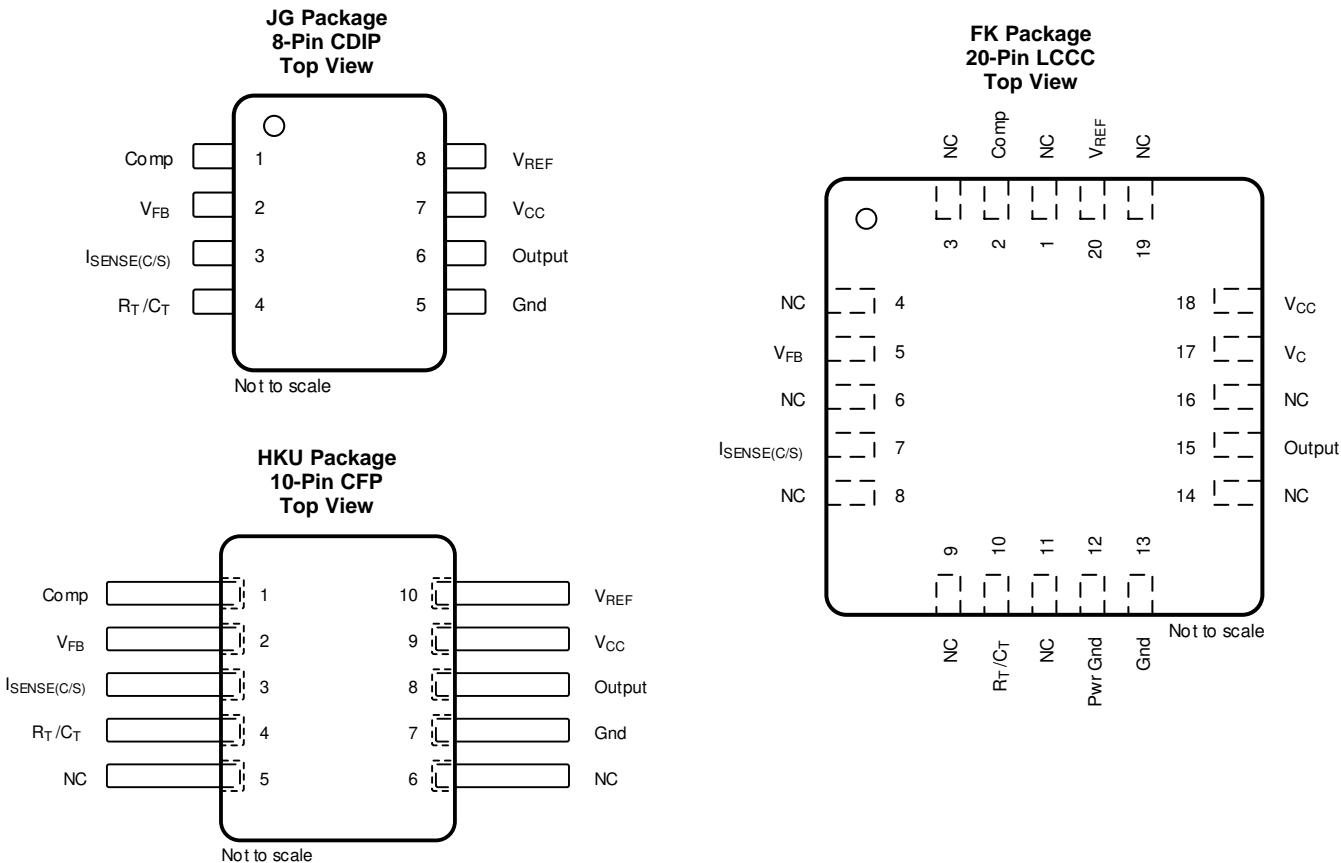
## 5 概要（続き）

デバイス比較表には、このファミリのメンバ間の相違点が示されています。放射線強化版が利用可能かどうか、および注文方法については、各製品のデータシートを参照してください。

## 6 Device Comparison Table

PART NO.	UVLO ON	UVLO OFF	MAXIMUM DUTY CYCLE
UC1842A	16 V	10 V	<100%
UC1843A	8.5 V	7.9 V	<100%
UC1844A	16 V	10 V	<50%
UC1845A	8.5 V	7.9 V	<50%

## 7 Pin Configuration and Functions



### Pin Functions

NAME	PIN			I/O	DESCRIPTION
	CDIP	LCCC	CFP		
Comp	1	2	1	I	Error amplifier output.
V <sub>FB</sub>	2	5	2	I	Voltage feedback input to error amplifier.
I <sub>SENSE(C/S)</sub>	3	7	3	I	Current sense comparator input pin.
R <sub>T</sub> /C <sub>T</sub>	4	10	4	I	RC time constant input to oscillator.
NC	—	1, 3, 4, 6, 8, 9, 11, 14, 16, 19	5, 6	—	No connect.
Pwr Gnd	—	12	—	—	Output section ground.
Gnd	5	13	7	—	Ground.
Output	6	15	8	O	Regulated output.
V <sub>C</sub>	—	17	—	—	Output section supply voltage.
V <sub>CC</sub>	7	18	9	—	Unregulated supply voltage.

### Pin Functions (continued)

PIN				I/O	DESCRIPTION
NAME	CDIP	LCCC	CFP		
V <sub>REF</sub>	8	20	10	O	5-V internally generated reference.

## 8 Specifications

### 8.1 Absolute Maximum Ratings<sup>(1)(2)</sup>

over operating free-air temperature (unless otherwise noted)

		MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage, low-impedance source		30	V
V <sub>I</sub>	Input voltage (V <sub>FB</sub> , I <sub>SENSE</sub> )	-0.3	6.3	V
	Supply current	Self limiting		
I <sub>O</sub>	Output current		±1	A
	Error amplifier output sink current		10	mA
	Output energy (capacitive load)		5	μJ
P <sub>D</sub>	Power dissipation (T <sub>A</sub> = 25°C)		1	W
T <sub>J</sub>	Junction temperature		150	°C
T <sub>stg</sub>	Storage temperature	-65	150	°C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltages are with respect to ground. Currents are positive in, negative out of the specified terminal.

### 8.2 ESD Ratings

		VALUE	UNIT
V <sub>(ESD)</sub>	Electrostatic discharge Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±4000	V

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

### 8.3 Recommended Operating Conditions

over operating free-air temperature range (T<sub>A</sub> = T<sub>J</sub> = -55°C to 125°C), unless otherwise noted

		MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage	12	25	V
	Sink/source output current (continuous or time average)	0	200	mA
	Reference load current	0	20	mA

### 8.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>	UC1845A-SP			UNIT	
	JG (CDIP)	FK (LCCC)	HKU (CFP)		
	8 PINS	20 PINS	10 PINS		
R <sub>θJA</sub>	Junction-to-ambient thermal resistance	103	—	51.9	°C/W
R <sub>θJC(bot)</sub>	Junction-to-case (bottom) thermal resistance	9.6	9.0	6.6	°C/W
R <sub>θJB</sub>	Junction-to-board thermal resistance	69.2	—	31.5	°C/W
Ψ <sub>JT</sub>	Junction-to-top characterization parameter	13.9	—	5.42	°C/W
Ψ <sub>JB</sub>	Junction-to-board characterization parameter	73	—	31	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

## 8.5 Electrical Characteristics

$V_{CC} = 15 \text{ V}^{(1)}$ ,  $R_T = 10 \text{ k}\Omega$ ,  $C_T = 3.3 \text{ nF}$ ,  $T_A = T_J = -55^\circ\text{C}$  to  $125^\circ\text{C}$  (unless otherwise noted) <sup>(2)</sup>

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
<b>REFERENCE</b>						
Output voltage	$T_J = 25^\circ\text{C}$ , $I_O = 1 \text{ mA}$ , $V_{CC} = 15 \text{ V}$	5962-8670408VxA	4.95	5	5.06	
		5962P8670411Vxx Pre-radiation	4.94	5	5.06	
		5962P8670411Vxx Post-radiation	4.85		5.06	
Line regulation	$V_{IN} = 12$ to $25 \text{ V}$		6	20	$\text{mV}$	
Load regulation	$I_O = 1$ to $20 \text{ mA}$		6	25	$\text{mV}$	
Temperature stability <sup>(3)(4)(5)</sup>			0.2	0.4	$\text{mV}/^\circ\text{C}$	
Total output variation <sup>(3)</sup>	Over line, load, and temperature	4.9	5.1		$\text{V}$	
Output noise variation	$10 \text{ Hz} \leq f \leq 10 \text{ kHz}$ , $T_J = 25^\circ\text{C}$		50		$\mu\text{V}$	
Long-term stability <sup>(5)</sup>	1000 hours, $T_A = 125^\circ\text{C}$ <sup>(3)</sup>		5	25	$\text{mV}$	
Short-circuit output current			-30	-100	-180	$\text{mA}$
<b>OSCILLATOR</b>						
Initial accuracy	$T_J = 25^\circ\text{C}$ <sup>(6)</sup>	47	52	57	$\text{kHz}$	
Voltage stability	$V_{CC} = 12$ to $25 \text{ V}$		0.2%	1%		
Temperature stability	$T_J = -55^\circ\text{C}$ to $125^\circ\text{C}$ <sup>(3)</sup>		5%			
Amplitude	$V_{RT/CT}$ peak to peak <sup>(3)</sup>		1.7		$\text{V}$	
Discharge current	$V$ pin 4 = $2 \text{ V}$ <sup>(7)</sup>	$T_J = 25^\circ\text{C}$	7.8	8.3	8.8	$\text{mA}$
		$T_J = \text{Full range}$	7.5		8.8	$\text{mA}$
<b>ERROR AMPLIFIER</b>						
Input voltage	$V_{Comp} = 2.5 \text{ V}$	2.45	2.50	2.55	$\text{V}$	
Input bias current			-0.3	-1	$\mu\text{A}$	
Open-loop voltage gain	$V_O = 2$ to $4 \text{ V}$	65	90		$\text{dB}$	
Unity-gain bandwidth	$T_J = 25^\circ\text{C}$ <sup>(3)</sup>	0.7	1		$\text{MHz}$	
PSRR	$V_{CC} = 12$ to $25 \text{ V}$	60	70		$\text{dB}$	
Output sink current	$V_{FB} = 2.7 \text{ V}$ , $V_{Comp} = 1.1 \text{ V}$	2	6		$\text{mA}$	
Output source current	$V_{FB} = 2.3 \text{ V}$ , $V_{Comp} = 5 \text{ V}$	-0.5	-0.8		$\text{mA}$	
High-level output voltage	$V_{FB} = 2.3 \text{ V}$ , $R_L = 15 \text{ k}\Omega$ to ground	5	6		$\text{V}$	
Low-level output voltage	$V_{FB} = 2.7 \text{ V}$ , $R_L = 15 \text{ k}\Omega$ to $V_{REF}$		0.7	1.1	$\text{V}$	
<b>CURRENT SENSE</b>						
Gain <sup>(8)(9)</sup>		2.85	3	3.15	$\text{V}/\text{V}$	
Maximum input signal	$V_{Comp} = 5 \text{ V}$ <sup>(8)</sup>	0.9	1	1.1	$\text{V}$	
PSRR	$V_{CC} = 12$ to $25 \text{ V}$ <sup>(8)</sup>		70		$\text{dB}$	
Input bias current			-2	-10	$\mu\text{A}$	
Delay to output	$V_{ISENSE} = 0$ to $2 \text{ V}$ <sup>(3)</sup>		150	300	$\text{ns}$	

(1) Adjust  $V_{CC}$  above the start threshold before setting at 15 V.

(2) See [メカニカル、パッケージ、および注文情報](#) for radiation improved devices.

(3) Parameters ensured by design and/or characterization, if not production tested.

(4) Temperature stability, sometimes referred to as average temperature coefficient, is described by the equation:

Temperature Stability =  $V_{REF}$  (max) –  $V_{REF}$  (min) /  $T_J$  (max) –  $T_J$  (min).  $V_{REF}$  (max) and  $V_{REF}$  (min) are the maximum and minimum reference voltage measured over the appropriate temperature range. Note that the extremes in voltage do not necessarily occur at the extremes in temperature.

(5) Parameter applies only for 5962-8670408VxA.

(6) Output frequency is one-half oscillator frequency for UC1845A.

(7) This parameter is measured with  $R_T = 10 \text{ k}\Omega$  to  $V_{REF}$ . This contributes approximately 300  $\mu\text{A}$  of current to the measurement. The total current flowing into the  $R_T$  or  $C_T$  pin will be approximately 300  $\mu\text{A}$  higher than the measured value.

(8) Parameter measured at trip point of latch with  $V_{FB} = 0 \text{ V}$ .

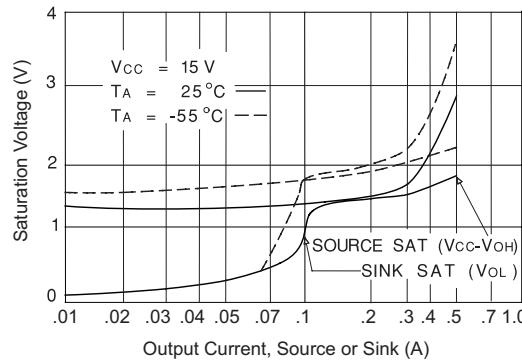
(9) Gain defined as:  $G = \Delta V_{Comp} / \Delta V_{ISENSE}$ ;  $V_{ISENSE} = 0$  to 0.8 V.

## Electrical Characteristics (continued)

$V_{CC} = 15 \text{ V}^{(1)}$ ,  $R_T = 10 \text{ k}\Omega$ ,  $C_T = 3.3 \text{ nF}$ ,  $T_A = T_J = -55^\circ\text{C}$  to  $125^\circ\text{C}$  (unless otherwise noted)<sup>(2)</sup>

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>OUTPUT</b>					
Output low-level voltage	$I_{SINK} = 20 \text{ mA}$	0.1	0.4		V
	$I_{SINK} = 200 \text{ mA}$	1.5	2.2		
Output high-level voltage	$I_{SOURCE} = -20 \text{ mA}$	13	13.5		V
	$I_{SOURCE} = -200 \text{ mA}$	12	13.5		
Rise time	$C_L = 1 \text{ nF}$ , $T_J = 25^\circ\text{C}^{(3)}$	50	150		ns
Fall time	$C_L = 1 \text{ nF}$ , $T_J = 25^\circ\text{C}^{(3)}$	50	150		ns
UVLO saturation	$V_{CC} = 5 \text{ V}$ , $I_{SINK} = 10 \text{ mA}$	0.7	1.2		V
<b>UNDERVOLTAGE LOCKOUT</b>					
Start threshold		7.8	8.4	9	V
Minimum operation voltage after turnon		7	7.6	8.2	V
<b>PWM</b>					
Maximum duty cycle		47%	48%	50%	
Minimum duty cycle				0%	
<b>TOTAL STANDBY CURRENT</b>					
Start-up current		0.3	0.5		mA
Operating supply current	$V_{FB} = V_{ISENSE} = 0 \text{ V}$	11	17		mA
$V_{CC}$ Zener voltage	$I_{CC} = 25 \text{ mA}$	30	34		V

## 8.6 Typical Characteristics



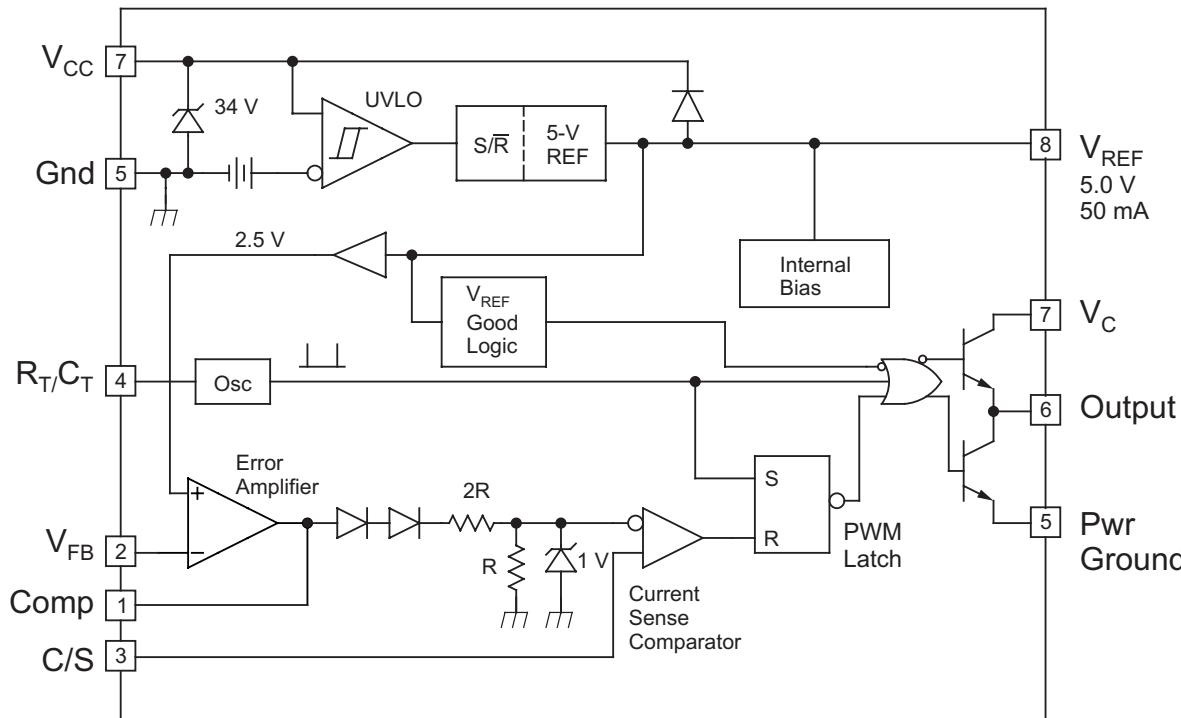
**Figure 1. Output Saturation Characteristics**

## 9 Detailed Description

### 9.1 Overview

The UC1845A-SP control IC is a pin-for-pin compatible improved version of the UC184x family. Providing the necessary characteristics to control current-mode switched-mode power supplies, this device has improved features. Start-up current is specified to be less than 0.5 mA and oscillator discharge is trimmed to 8.3 mA. During UVLO, the output stage can sink at least 10 mA at less than 1.2 V for  $V_{CC}$  over 5 V.

### 9.2 Functional Block Diagram



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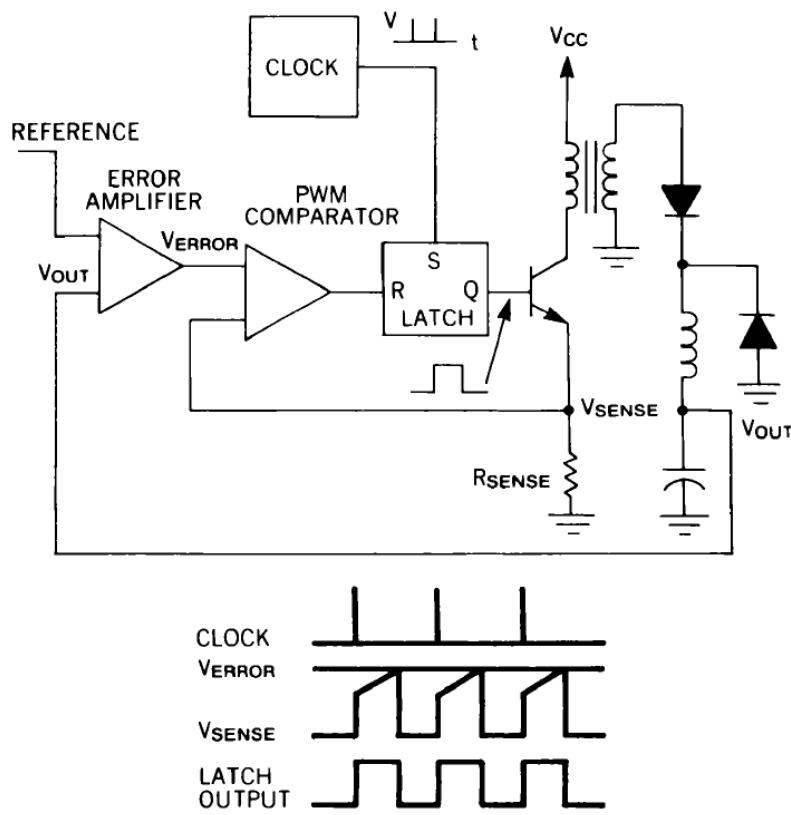
### 9.3 Feature Description

UC1845A-SP is a current mode controller, used to support various topologies such as forward, flyback, buck, boost and using an external interface circuit will also support half-bridge, full-bridge, and push-pull configurations.

Figure 2 shows the two-loop current-mode control system in a typical buck regulator application. A clock signal initiates power pulses at a fixed frequency. The termination of each pulse occurs when an analog of the inductor current reaches a threshold established by the error signal. In this way, the error signal actually controls peak inductor current. This contrasts with conventional schemes in which the error signal directly controls pulse width without regard to inductor current.

Several performance advantages result from the use of current-mode control. First, an input voltage feed-forward characteristic is achieved; that is, the control circuit instantaneously corrects for input voltage variations without using up any of the error amplifier's dynamic range. Therefore, line regulation is excellent and the error amplifier can be dedicated to correcting for load variations exclusively.

## Feature Description (continued)



0019-1

**Figure 2. Two-Loop Current-Mode Control System**

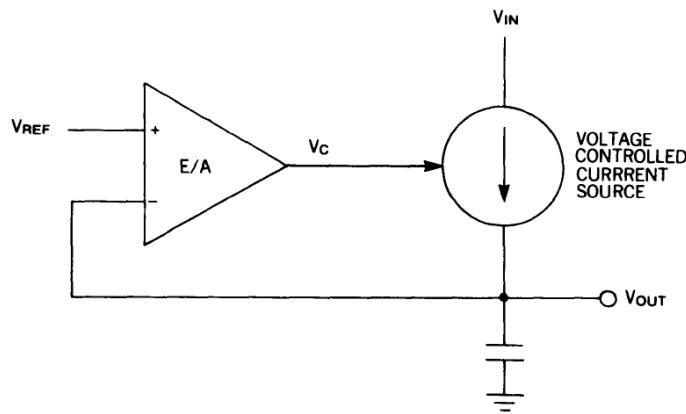
For converters in which inductor current is continuous, controlling peak current is nearly equivalent to controlling average current. Therefore, when such converters employ current-mode control, the inductor can be treated as an error-voltage-controlled-current-source for the purposes of small-signal analysis (see [Figure 3](#)). The two-pole control-to-output frequency response of these converters is reduced to a single-pole (filter capacitor in parallel with load) response. One result is that the error amplifier compensation can be designed to yield a stable closed-loop converter response with greater gain bandwidth than would be possible with pulse-width control, giving the supply improved small-signal dynamic response to changing loads. A second result is that the error amplifier compensation circuit becomes simpler, as shown in [Figure 4](#).

Capacitor  $C_i$  and resistor  $R_i$ , in [Figure 4\(A\)](#), add a low-frequency zero, which cancels one of the two control-to-output poles of non-current-mode converters. For large signal load changes, in which converter response is limited by inductor slew rate, the error amplifier saturates while the inductor is catching up with the load. During this time,  $C_i$  charges to an abnormal level. When the inductor current reaches its required level, the voltage on  $C_i$  causes a corresponding error in supply output voltage. The recovery time is  $R_{iz}C_i$ , which may be long. However, the compensation network of [Figure 4\(B\)](#) can be used where current-mode control has eliminated the inductor pole. Large-signal dynamic response is then greatly improved due to the absence of  $C_i$ .

Current limiting is greatly simplified with current-mode control. Pulse-by-pulse limiting is, of course, inherent in the control scheme. Furthermore, an upper limit on the peak current can be established by simply clamping the error voltage. Accurate current limiting allows optimization of magnetic and power semiconductor elements while ensuring reliable supply operation.

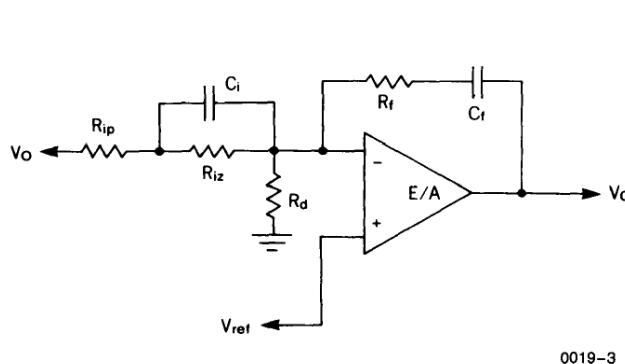
Finally, current-mode controlled power stages can be operated in parallel with equal current sharing. This opens the possibility of a modular approach to power supply design.

## Feature Description (continued)

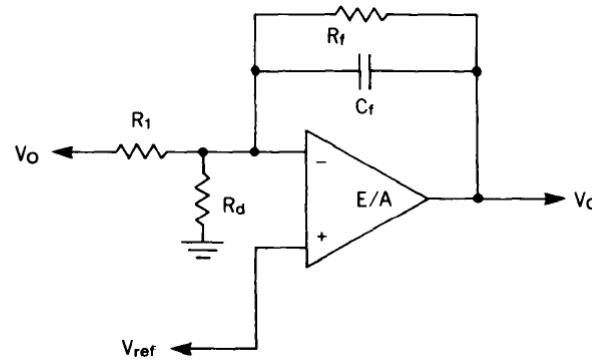


0019-2

**Figure 3. Inductor Looks Like a Current Source to Small Signals**



A. Direct duty cycle control



B. Current mode control

**Figure 4. Required Error Amplifier Compensation for Continuous Inductor Current Designs**

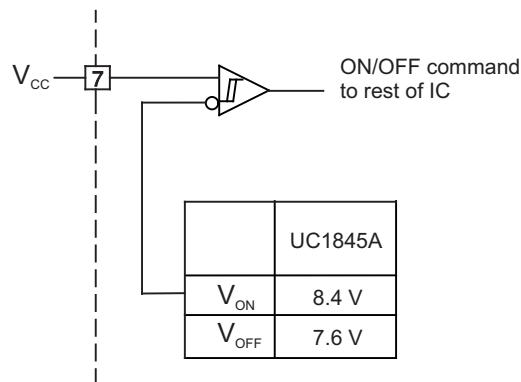
### 9.3.1 UVLO

The UVLO circuit ensures that  $V_{CC}$  is adequate to make the UC1845A-SP fully operational before enabling the output stage. Figure 5 shows that the UVLO turnon and turnoff thresholds are fixed internally at 8.5 V and 7.9 V, respectively. The 0.6-V hysteresis prevents  $V_{CC}$  oscillations during power sequencing.

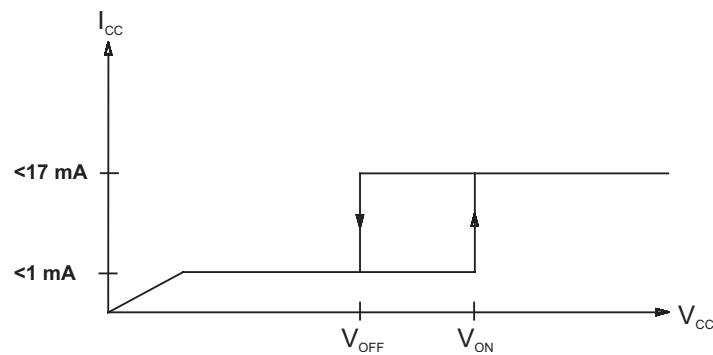
Figure 6 shows supply current requirements. Start-up current is  $< 1$  mA for efficient bootstrapping from the rectified input of an off-line converter, as shown in Figure 7. During normal circuit operation,  $V_{CC}$  is developed from auxiliary winding,  $WAux$ , with  $D_1$  and  $C_{IN}$ . However, at start-up,  $C_{IN}$  must be charged to 16 V through  $R_{IN}$ . With a start-up current of 1 mA,  $R_{IN}$  can be as large as 100 k $\Omega$  and still charge  $C_{IN}$  when  $V_{AC} = 90$ -V RMS (low line). Power dissipation in  $R_{IN}$  would then be less than 350 mW even under high line ( $V_{AC} = 130$ -V RMS) conditions.

During UVLO, the output driver is in a low state. While it does not exhibit the same saturation characteristics as normal operation, it can easily sink 1 mA, enough to ensure the MOSFET is held off.

## Feature Description (continued)

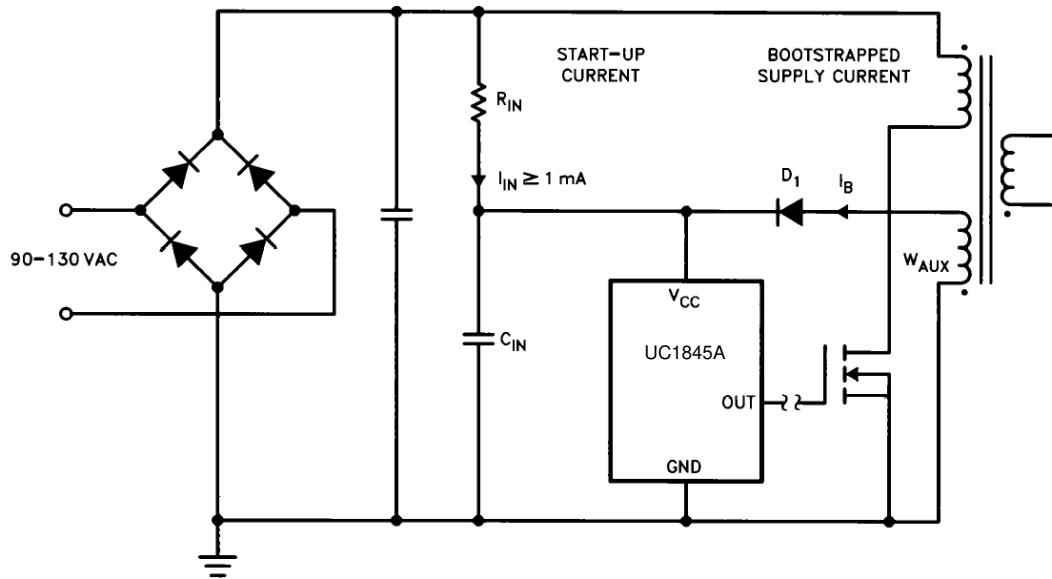


**Figure 5. UVLO Turnon TurnOff Threshold**



During UVLO, the output driver is biased to sink minor amounts of current.

**Figure 6. Supply Current Requirements**



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**Figure 7. Providing Power to the UC1845A-SP**

## Feature Description (continued)

### 9.3.2 Reference

As highlighted in the [Functional Block Diagram](#), UC1845A-SP incorporates a 5-V internal reference regulator with  $\pm 2\%$  set point variation over temperature.

### 9.3.3 Totem-Pole Output

The UC1845A-SP PWM has a single totem-pole output which can be operated to  $\pm 1$ -A peak for driving MOSFET gates, and a +200 mA average current for bipolar power U-100A transistors. Cross conduction between the output transistors is minimal, the average added power with  $V_{IN} = 30$  V is only 80 mW at 200 kHz.

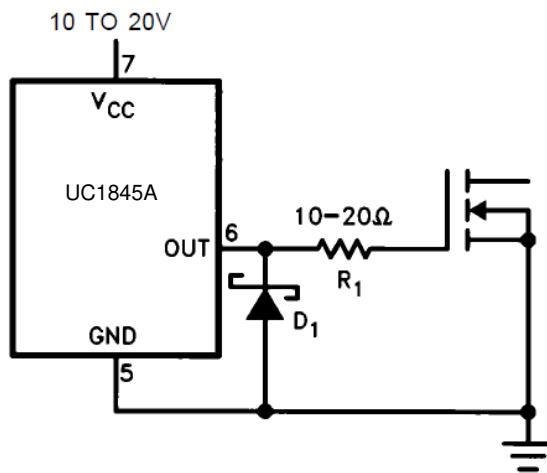
Limiting the peak current through the IC is accomplished by placing a resistor between the totem-pole output and the gate of the MOSFET. The value is determined by dividing the totem-pole collector voltage  $V_C$  by the peak current rating of the IC's totem-pole. Without this resistor, the peak current is limited only by the  $dV/dT$  rate of the totem-pole switching and the FET gate capacitance.

The use of a Schottky diode from the PWM output to ground prevents the output voltage from going excessively below ground, causing instabilities within the IC. To be effective, the diode selected should have a forward drop of less than 0.3 V at 200 mA. Most 1- to 3-A Schottky diodes exhibit these traits above room temperature. Placing the diode as physically close to the PWM as possible enhances circuit performance. Implementation of the complete drive scheme is shown in [Figure 8](#) through [Figure 10](#). Transformer-driven circuits also require the use of the Schottky diodes to prevent a similar set of circumstances from occurring on the PWM output. The ringing below ground is greatly enhanced by the transformer leakage inductance and parasitic capacitance, in addition to the magnetizing inductance and FET gate capacitance. Circuit implementation is similar to the previous example.

[Figure 8](#) through [Figure 10](#) show suggested circuits for driving MOSFETs and bipolar transistors with the UC1845A-SP output. The simple circuit of [Figure 8](#) can be used when the control IC is not electrically isolated from the MOSFET turnon and turnoff to  $\pm 1$  A. It also provides damping for a parasitic tank circuit formed by the FET input capacitance and series wiring inductance. Schottky diode,  $D_1$ , prevents the output of the IC from going far below ground during turnoff.

[Figure 9](#) shows an isolated MOSFET drive circuit which is appropriate when the drive signal must be level shifted or transmitted across an isolation boundary. Bipolar transistors can be driven efficiently with the circuit of [Figure 10](#). Resistors  $R_1$  and  $R_2$  fix the on-state base current while capacitor  $C_1$  provides a negative base current pulse to remove stored charge at turnoff.

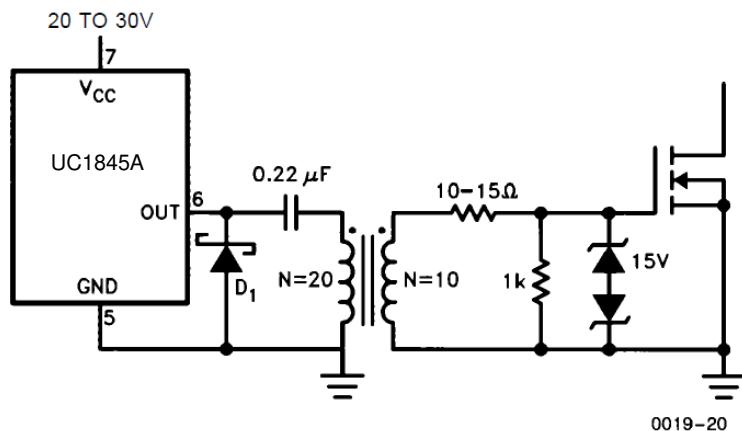
Because the UC1845A-SP series has only a single output, an interface circuit is needed to control push-pull, half-bridge, or full-bridge topologies. The UC1706 dual output driver with internal toggle flip-flop performs this function. [Typical Application](#) shows a typical application for these two ICs. Increased drive capability for driving numerous FETs in parallel, or other loads can be accomplished using one of the UC1705/6/7 driver ICs.



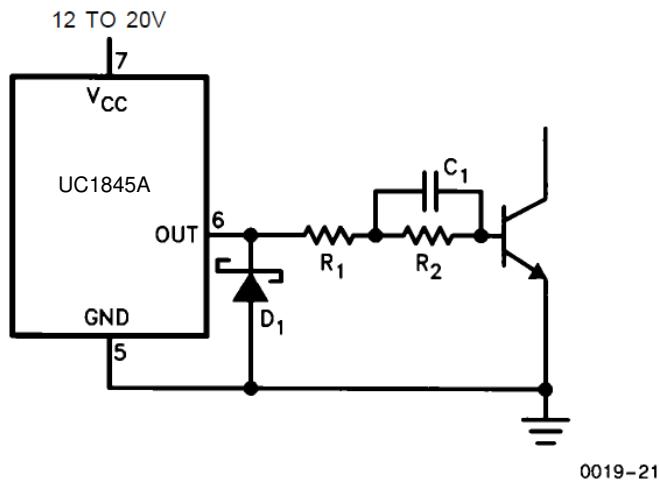
0019-19

**Figure 8. Direct MOSFET Drive**

## Feature Description (continued)



**Figure 9. Isolated MOSFET Drive**



**Figure 10. Bipolar Drive With Negative turnoff Bias**

### 9.4 Device Functional Modes

The UC1845A-SP uses fixed frequency, peak current mode control. An internal oscillator initiates the turn on of the driver to high-side power switch. The external power switch current is sensed through an external resistor and is compared via internal comparator. The voltage generated at the COMP pin is stepped down via internal resistors (as shown in the functional block diagram). When the sensed current reaches the stepped down COMP voltage, the high-side power switch is turned off.

## 10 Application and Implementation

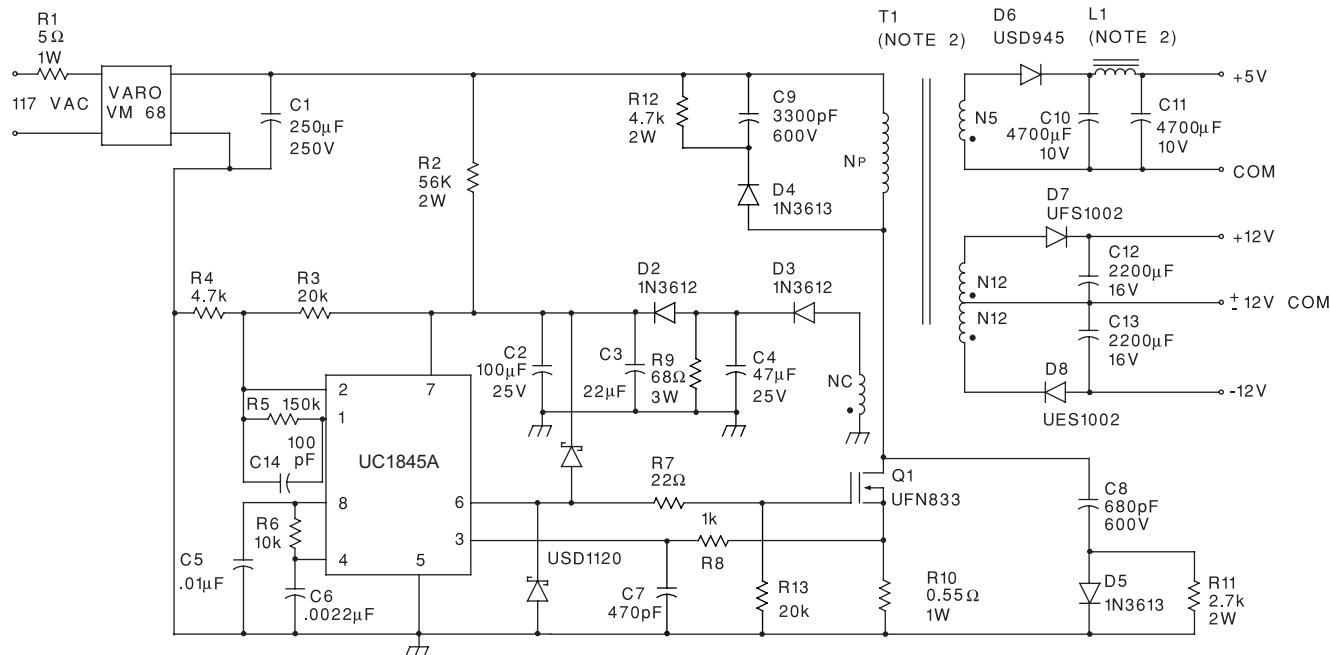
### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 10.1 Application Information

UC1845A-SP can be used as a controller to design various topologies such as buck, boost, flyback, and forward. Using an external interphase circuit can also support push-pull, half-bridge and full-bridge topologies.

### 10.2 Typical Application



## 10.2.2 Detailed Design Procedure

See [Table 2](#) for component values.

**Table 2. Components<sup>(1)</sup>**

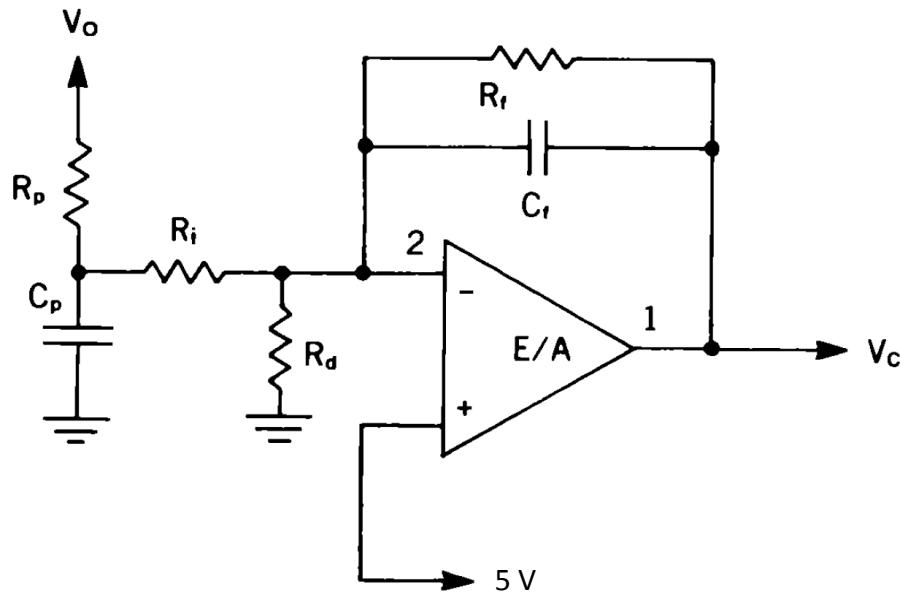
COMPONENT	VALUE
R1	5 $\Omega$ , 1 W
R2	56 k $\Omega$ , 2 W
R3	20 k $\Omega$
R4	4.7 k $\Omega$
R5	150 k $\Omega$
R6	10 k $\Omega$
R7	22 $\Omega$
R8	1 k $\Omega$
R9	68 $\Omega$
R10	0.55 $\Omega$ , 1 W
R11	2.7 k $\Omega$ , 2 W
R12	4.7 k $\Omega$ , 2 W
R13	20 k $\Omega$
C1	250 $\mu$ F, 250 V
C2	100 $\mu$ F, 25 V
C3	22 $\mu$ F
C4	47 $\mu$ F, 25 V
C5	0.1 $\mu$ F
C6	0.0022 $\mu$ F
C7	470 pF
C8	680 pF, 600 V
C9	3300 pF, 600 V
C10	4700 $\mu$ F, 10 V
C11	4700 $\mu$ F, 10 V
C12	2200 $\mu$ F, 10 V
C13	2200 $\mu$ F, 10 V
C14	100 pF
D2	1N3612
D3	1N3612
D4	1N3613
D5	1N3613
D6	USD945
D7	UFS1002
D8	UES1002
Q1	UFN833

(1) See [Figure 11](#) for reference.

### 10.2.2.1 Oscillator

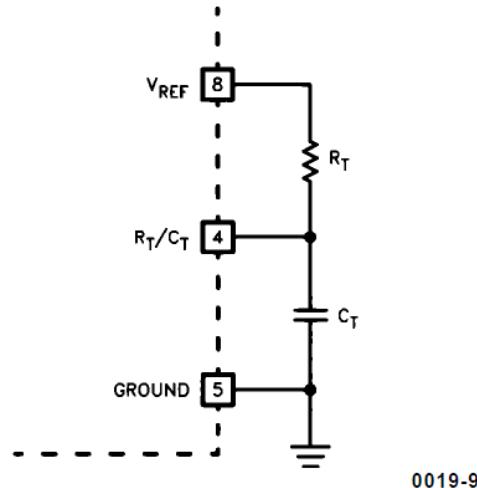
The UC1845A-SP oscillator is programmed as shown in [Figure 13](#). Timing capacitor  $C_T$  is charged from VREF (5 V) through the timing resistor  $R_T$ , and discharged by an internal current source. The first step in selecting the oscillator components is to determine the required circuit dead time. Once obtained, [Figure 14](#) is used to pinpoint the nearest standard value of  $C_T$  for a given dead time. Next, the appropriate  $R_T$  value is interpolated using the parameters for  $C_T$  and oscillator frequency. [Figure 15](#) shows the  $R_T/C_T$  combinations versus oscillator frequency. The timing resistor can be calculated from the following formula.

$$f_{\text{osc}} \text{ (kHz)} = \frac{1.72}{RT \text{ (k}\Omega\text{)} \times CT \text{ (}\mu\text{F)}} \quad (1)$$

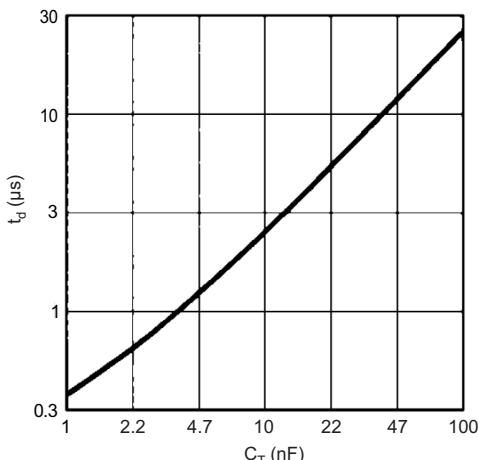
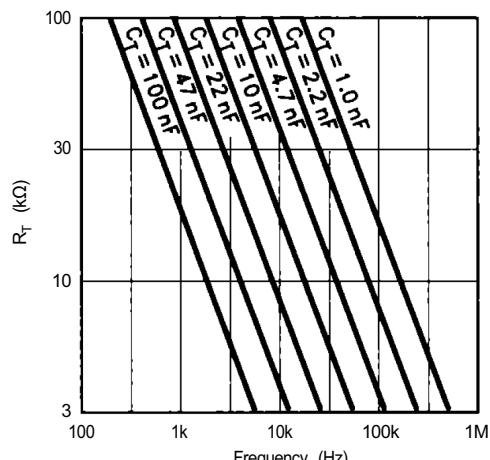


**Figure 12. E/A Compensation Circuit for Continuous Boost and Flyback Topologies**

The UC1845A-SP has an internal divide-by-two flip-flop driven by the oscillator for a 50% maximum duty cycle. Therefore, their oscillators must be set to run at twice the desired power supply switching frequency.



**Figure 13. Oscillator Programming**


**Figure 14. Dead Time vs  $C_T$  ( $R_T > 5 \text{ k}\Omega$ )**

**Figure 15. Timing Resistance vs Frequency**

### 10.2.2.2 Current Sensing and Limiting

The UC1845A-SP current sense input is configured as shown in [Figure 16](#). Current-to-voltage conversion is done externally with ground-referenced resistor  $R_S$ . Under normal operation, the peak voltage across  $R_S$  is controlled by the E/A according to the following relation:

$$I_P = \frac{V_C - 1.4 \text{ V}}{3 R_S}$$

where

- $V_C$  = Control voltage = E/A output voltage

(2)

$R_S$  can be connected to the power circuit directly or through a current transformer, as [Figure 16](#) shows. While a direct connection is simpler, a transformer can reduce power dissipation in  $R_S$ , reduce errors caused by the base current, and provide level shifting to eliminate the restraint of ground-referenced sensing. The relation between  $V_C$  and peak current in the power stage is given by:

$$i_{(pk)} = N \left( \frac{V_{R_S(pk)}}{R_S} \right) = \frac{N}{3 R_S} (V_C - 1.4 \text{ V})$$

where

- $N$  = Current sense transformer turns ratio = 1 when transformer not used.

(3)

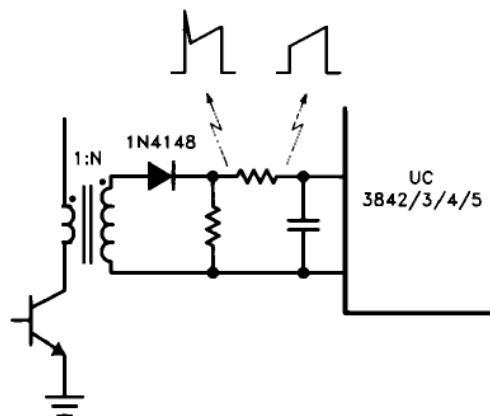
For purposes of small-signal analysis, the control-to-sensed-current gain is:

$$\frac{i_{(pk)}}{V_C} = \frac{N}{3 R_S}$$
(4)

When sensing current in series with the power transistor, as shown in [Figure 16](#), the current waveform often has a large spike at its leading edge. This spike is due to rectifier recovery and/or inter-winding capacitance in the power transformer. If unattenuated, this transient can prematurely terminate the output pulse. As shown, a simple RC filter is usually adequate to suppress this spike. The RC time constant should be approximately equal to the current spike duration (usually a few hundred nanoseconds).

The inverting input to the UC1845A-SP current-sense comparator is internally clamped to 1 V ([Figure 16](#)). Current limiting occurs if the voltage at pin 3 reaches this threshold value, that is, the current limit is defined by:

$$i_{max} = \frac{N \times 1 \text{ V}}{R_S}$$
(5)



0019-13

Figure 16. Transformer-Coupled Current Sensing

#### 10.2.2.3 Error Amplifier

The error amplifier (E/A) configuration is shown in [Figure 17](#). The non-inverting input is not brought out to a pin, but is internally biased to  $5\text{ V} \pm 2\%$ . The E/A output is available at pin 1 for external compensation, allowing the user to control the converter's closed-loop frequency response.

[Figure 18](#) shows an E/A compensation circuit suitable for stabilizing any current-mode controlled topology except for flyback and boost converters operating with inductor current. The feedback components add a pole to the loop transfer function at  $f_p = \frac{1}{2} \pi R_F C_F$ .  $R_F$  and  $C_F$  are chosen so that this pole cancels the zero of the output filter capacitor ESR in the power circuit.  $R_I$  and  $R_F$  fix the low-frequency gain. They are chosen to provide as much gain as possible while still allowing the pole formed by the output filter capacitor and load to roll off the loop gain to unity (0 dB) at  $f \approx f_{SWITCHING} / 4$ . This technique ensures converter stability while providing good dynamic response.

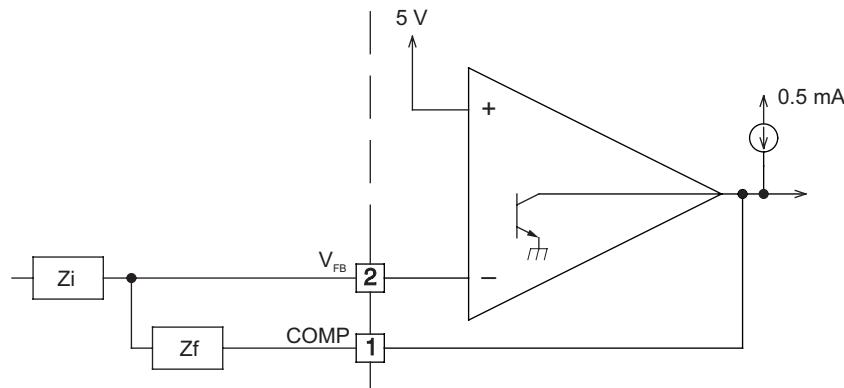
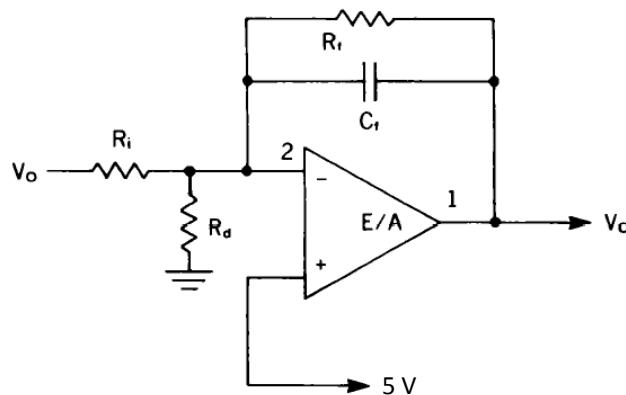


Figure 17. E/A Configuration



0019-15

**Figure 18. Compensation**

The E/A output sources 0.5 mA and sinks 2 mA. A lower limit for RF is given by:

$$R_{F(MIN)} \approx \frac{V_{EA\ OUT(MAX)} - 2.5\ V}{0.5\ mA} = \frac{6\ V - 2.5\ V}{0.5\ mA} = 7\ k\Omega \quad (6)$$

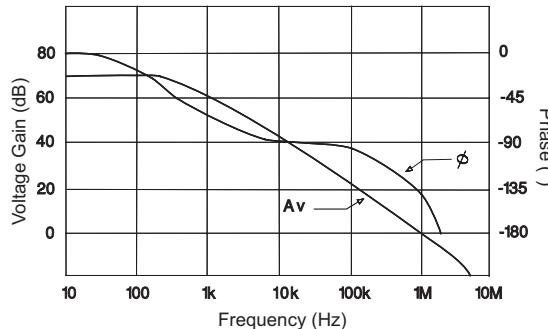
E/A input bias current (2- $\mu$ A max) flows through  $R_i$ , resulting in a DC error in output voltage ( $V_O$ ) given by:

$$\Delta V_{O(MAX)} = (2\ \mu A) R_i \quad (7)$$

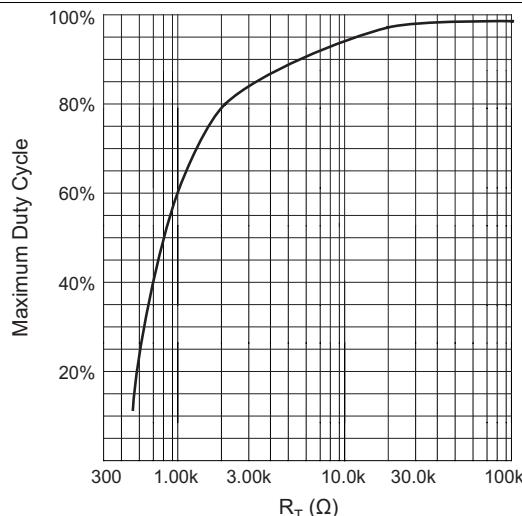
Therefore, the designer should keep the value of  $R_i$ , as low as possible.

**Figure 19** shows the open-loop frequency response of the UC1845A-SP E/A. The gain represents an upper limit on the gain of the compensated E/A. Phase lag increases rapidly as frequency exceeds 1 MHz due to second-order poles at about 10 MHz and above.

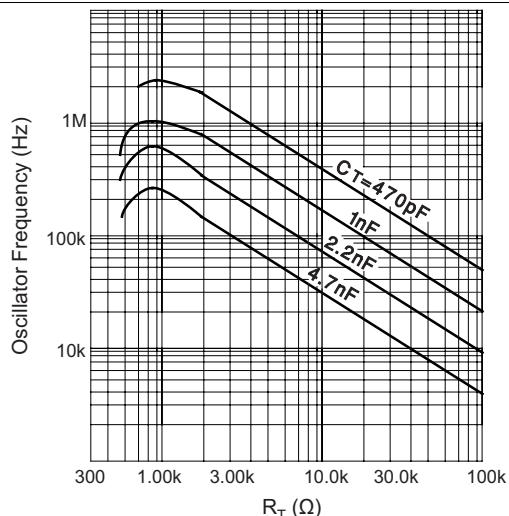
Continuous-inductor-current boost and flyback converters each have a right-half-plane zero in their transfer function. An additional compensation pole is needed to roll off loop gain at a frequency less than that of the RHP zero.  $R_P$  and  $C_P$  in the circuit of **Figure 12** provide this pole.


**Figure 19. Error Amplifier Open-Loop Frequency Response**

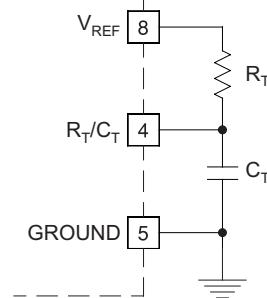
### 10.2.3 Application Curves



**Figure 20. Oscillator Frequency vs Timing Resistance**



**Figure 21. Maximum Duty Cycle vs Timing Resistor**

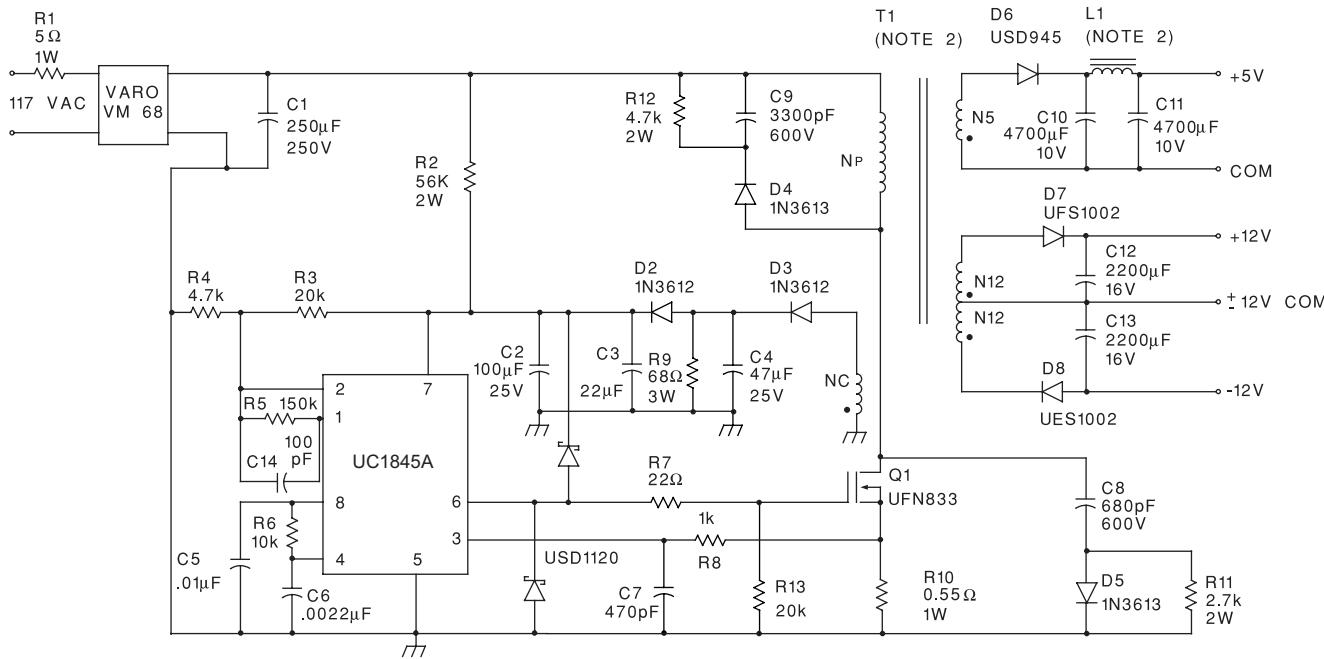


For  $R_T > 5k \quad f \approx 1.72 / (R_T C_T)$

**Figure 22. Oscillation Schematic**

## 11 Power Supply Recommendations

The devices are designed to operate from an input voltage supply range between 8 V and 40 V. This input supply should be well regulated. If the input supply is located more than a few inches from the UC1845A-SP converter, additional bulk capacitance may be required in addition to the ceramic bypass capacitors. A tantalum capacitor with a value of 47  $\mu$ F is a typical choice; however, this may vary depending upon the output power being delivered.



### Power supply specifications:

1. Input voltage: 95 VAC to 130 VAC (50 Hz/60 Hz)
2. Line isolation: 3750 V
3. Switching frequency: 40 kHz
4. Efficiency full load: 70%
5. Output voltage:
  - a. +5 V,  $\pm 5\%$ ; 1- to 4-A load, ripple voltage: 50 mVPP max
  - b. +12 V,  $\pm 3\%$ ; 0.1- to 0.3-A load, ripple voltage: 100 mVPP max
  - c. -12 V,  $\pm 3\%$ ; 0.1- to 0.3-A load, ripple voltage: 100 mVPP max

**Figure 23. Offline Flyback Regulator**

## 12 Layout

## 12.1 Layout Guidelines

Always try to use a low-EMI inductor with a ferrite-type closed core. Some examples would be toroid and encased E core inductors. Open core can be used if they have low-EMI characteristics and are located a farther away from the low-power traces and components. Make the poles perpendicular to the PCB as well if using an open core. Stick cores usually emit the most unwanted noise.

### 12.1.1 Feedback Traces

Try to run the feedback trace as far as possible from the inductor and noisy power traces. The designer should also make the feedback trace as direct as possible and somewhat thick. These two guidelines sometimes involve a trade-off, but keeping the trace away from inductor EMI and other noise sources is the more critical guideline. Run the feedback trace on the side of the PCB opposite of the inductor with a ground plane separating the two.

## Layout Guidelines (continued)

### 12.1.2 Input/Output Capacitors

When using a low-value ceramic input filter capacitor, locate it as close as possible to the VIN pin of the IC. This eliminates as much trace inductance effects as possible and gives the internal IC rail a cleaner voltage supply. Some designs require the use of a feed-forward capacitor connected from the output to the feedback pin as well, usually for stability reasons. In this case, it should also be positioned as close as possible to the IC. Using surface mount capacitors also reduces lead length and lessens the chance of noise coupling into the effective antenna created by through-hole components.

### 12.1.3 Compensation Components

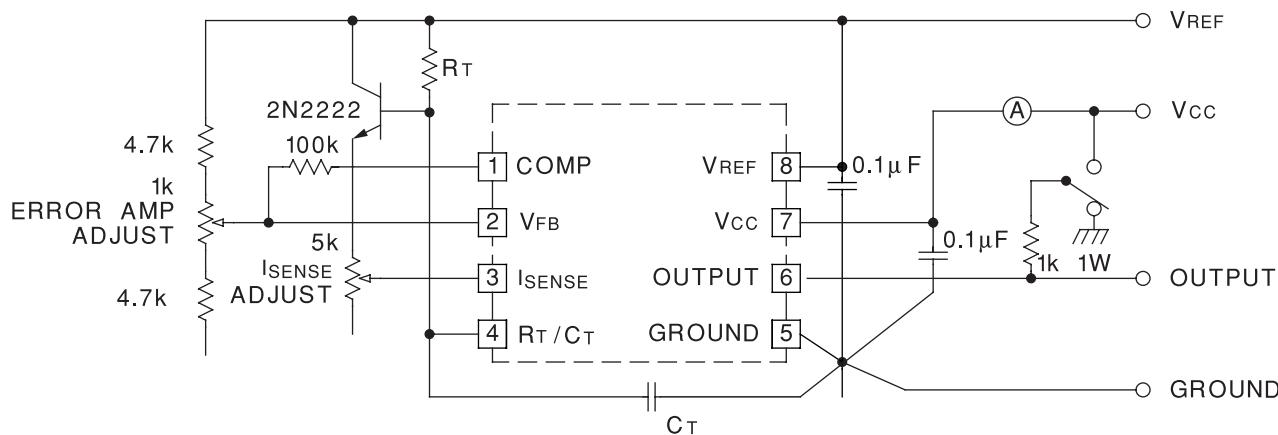
External compensation components for stability should also be placed close to the IC. TI recommends to also use surface mount components for the same reasons discussed for the filter capacitors. These should not be located very close to the inductor either.

### 12.1.4 Traces and Ground Planes

Make all of the power (high-current) traces as short, direct, and thick as possible. It is good practice on a standard PCB to make the traces an absolute minimum of 15 mils (0.381 mm) per ampere. The inductor, output capacitors, and output diode should be as close as possible to each other. This helps reduce the EMI radiated by the power traces due to the high-switching currents through them. This also reduces lead inductance and resistance, which in turn reduces noise spikes, ringing, and resistive losses that produce voltage errors. The grounds of the IC, input capacitors, output capacitors, and output diode (if applicable) should be connected close together directly to a ground plane. It would also be a good idea to have a ground plane on both sides of the PCB. This reduces noise by reducing ground loop errors and absorbing more of the EMI radiated by the inductor.

For multi-layer boards with more than two layers, a ground plane can be used to separate the power plane (where the power traces and components are) and the signal plane (where the feedback and compensation and components are) for improved performance. On multi-layer boards, vias are required to connect traces and different planes. It is a good practice to use one standard via per 200 mA of current if the trace needs to conduct a significant amount of current from one plane to the other. Arrange the components so that the switching current loops curl in the same direction. Due to the way switching regulators operate, there are two power states: one state when the switch is on and one when the switch is off. During each state there is a current loop made by the power components that are currently conducting. Place the power components so that during each of the two states the current loop is conducting in the same direction. This prevents magnetic field reversal caused by the traces between the two half-cycles and reduces radiated EMI.

## 12.2 Layout Example



High peak currents associated with capacitive loads necessitate careful grounding techniques. Timing and bypass capacitors should be connected close to pin 5 in a single point ground. The transistor and 5k potentiometer are used to sample the oscillator waveform and apply an adjustable ramp to pin 3.

**Figure 24. Open-Loop Laboratory Test Fixture**

## 13 デバイスおよびドキュメントのサポート

### 13.1 ドキュメントの更新通知を受け取る方法

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### 13.5 Glossary

[SLYZ022 — TI Glossary](#).

This glossary lists and explains terms, acronyms, and definitions.

## 14 メカニカル、パッケージ、および注文情報

以降のページには、メカニカル、パッケージ、および注文に関する情報が記載されています。この情報は、そのデバイスについて利用可能な最新のデータです。このデータは予告なく変更されることがあります。ドキュメントが改訂される場合もあります。本データシートのブラウザ版を使用されている場合は、画面左側の説明をご覧ください。

**PACKAGING INFORMATION**

Orderable part number	Status (1)	Material type (2)	Package   Pins	Package qty   Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
5962-8670408VPA	Active	Production	CDIP (JG)   8	50   TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	8670408VPA UC1845A
5962-8670408VPA.A	Active	Production	CDIP (JG)   8	50   TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	8670408VPA UC1845A
5962-8670408VXA	Active	Production	LCCC (FK)   20	55   TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962- 8670408VXA UC1845AL QMLV
5962-8670408VXA.A	Active	Production	LCCC (FK)   20	55   TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962- 8670408VXA UC1845AL QMLV
5962P8670411VPA	Active	Production	CDIP (JG)   8	50   TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	P8670411VPA UC1845A-SP
5962P8670411VPA.A	Active	Production	CDIP (JG)   8	50   TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	P8670411VPA UC1845A-SP
5962P8670411VYC	Active	Production	CFP (HKU)   10	25   TUBE	ROHS Exempt	NIAU	N/A for Pkg Type	-55 to 125	P8670411VYC UC1845A-SP
5962P8670411VYC.A	Active	Production	CFP (HKU)   10	25   TUBE	ROHS Exempt	NIAU	N/A for Pkg Type	-55 to 125	P8670411VYC UC1845A-SP

<sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

<sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

**(6) Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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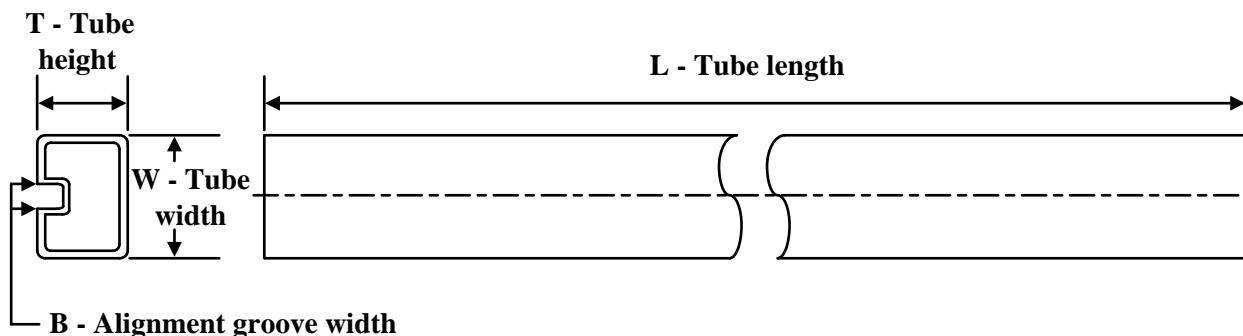
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

**OTHER QUALIFIED VERSIONS OF UC1845A-SP :**

- Catalog : [UC1845A](#)
- Enhanced Product : [UC1845A-EP](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product
- Enhanced Product - Supports Defense, Aerospace and Medical Applications

**TUBE**


\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T ( $\mu$ m)	B (mm)
5962-8670408VXA	FK	LCCC	20	55	506.98	12.06	2030	NA
5962-8670408VXA.A	FK	LCCC	20	55	506.98	12.06	2030	NA
5962P8670411VPA	JG	CDIP	8	50	506.98	15.24	13440	NA
5962P8670411VPA.A	JG	CDIP	8	50	506.98	15.24	13440	NA
5962P8670411VYC	HKU	CFP	10	25	506.98	26.16	6220	NA
5962P8670411VYC.A	HKU	CFP	10	25	506.98	26.16	6220	NA

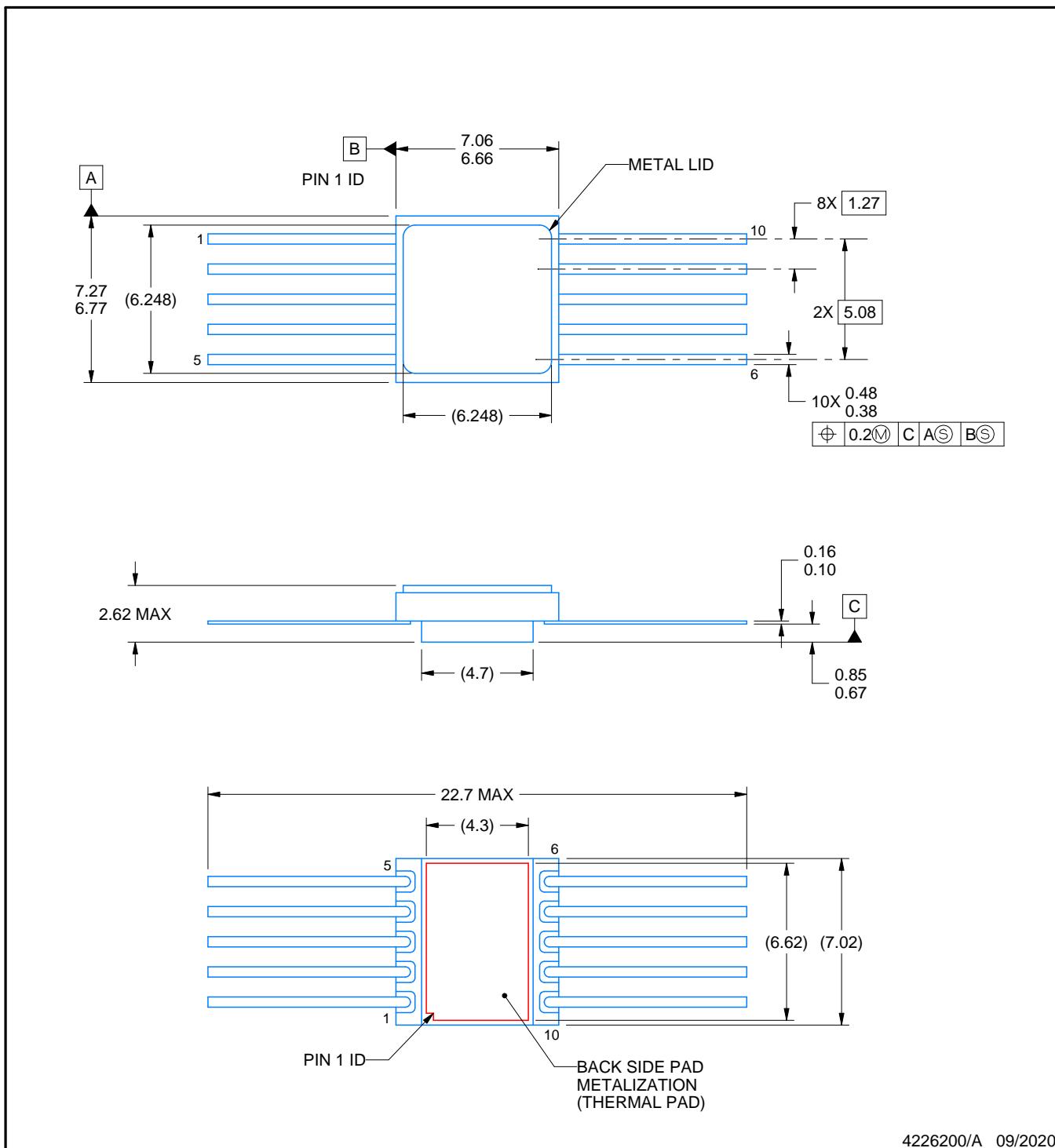
# PACKAGE OUTLINE

HKU0010A



CFP - 2.63mm max height

CERAMIC DUAL FLATPACK



4226200/A 09/2020

## NOTES:

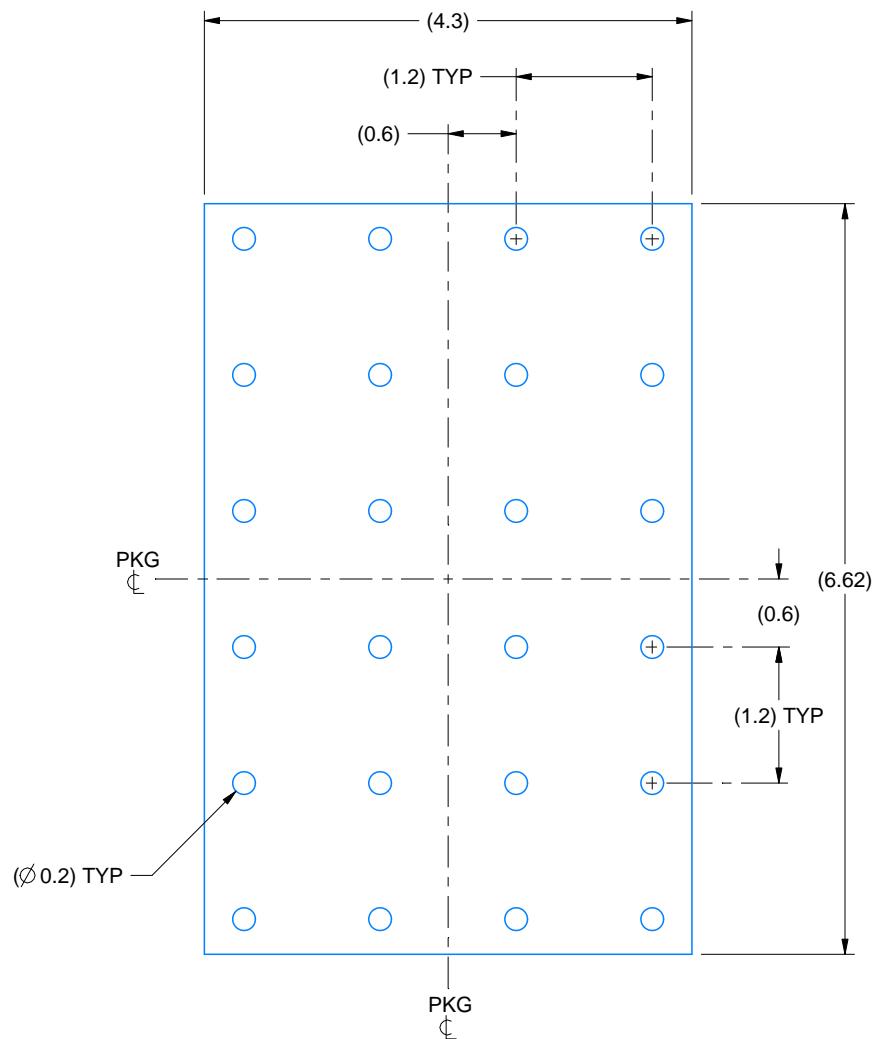
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This package is hermetically sealed with a metal lid.
4. The terminals are gold plated.
5. This drawing does not comply with MIL STD 1835. Do not use this package for compliant product.
6. Metal lid is connected to back side pad metalization.

## EXAMPLE BOARD LAYOUT

HKU0010A

**CFP - 2.63mm max height**

## CERAMIC DUAL FLATPACK



**HEATSINK LAND PATTERN EXAMPLE**  
**EXPOSED METAL SHOWN**  
**SCALE:15X**

# GENERIC PACKAGE VIEW

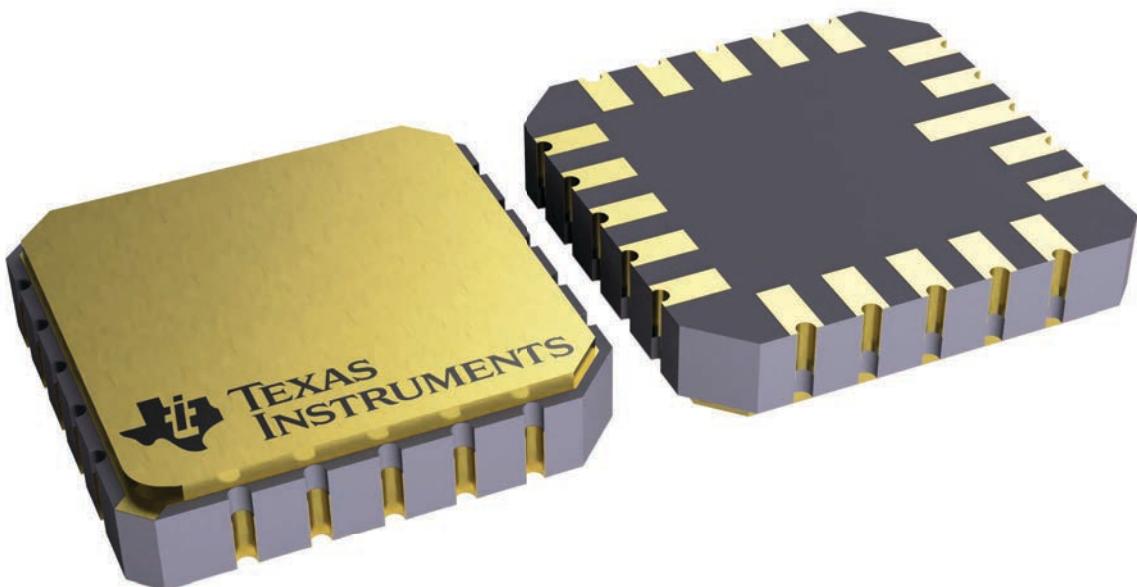
**FK 20**

**LCCC - 2.03 mm max height**

**8.89 x 8.89, 1.27 mm pitch**

**LEADLESS CERAMIC CHIP CARRIER**

This image is a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.



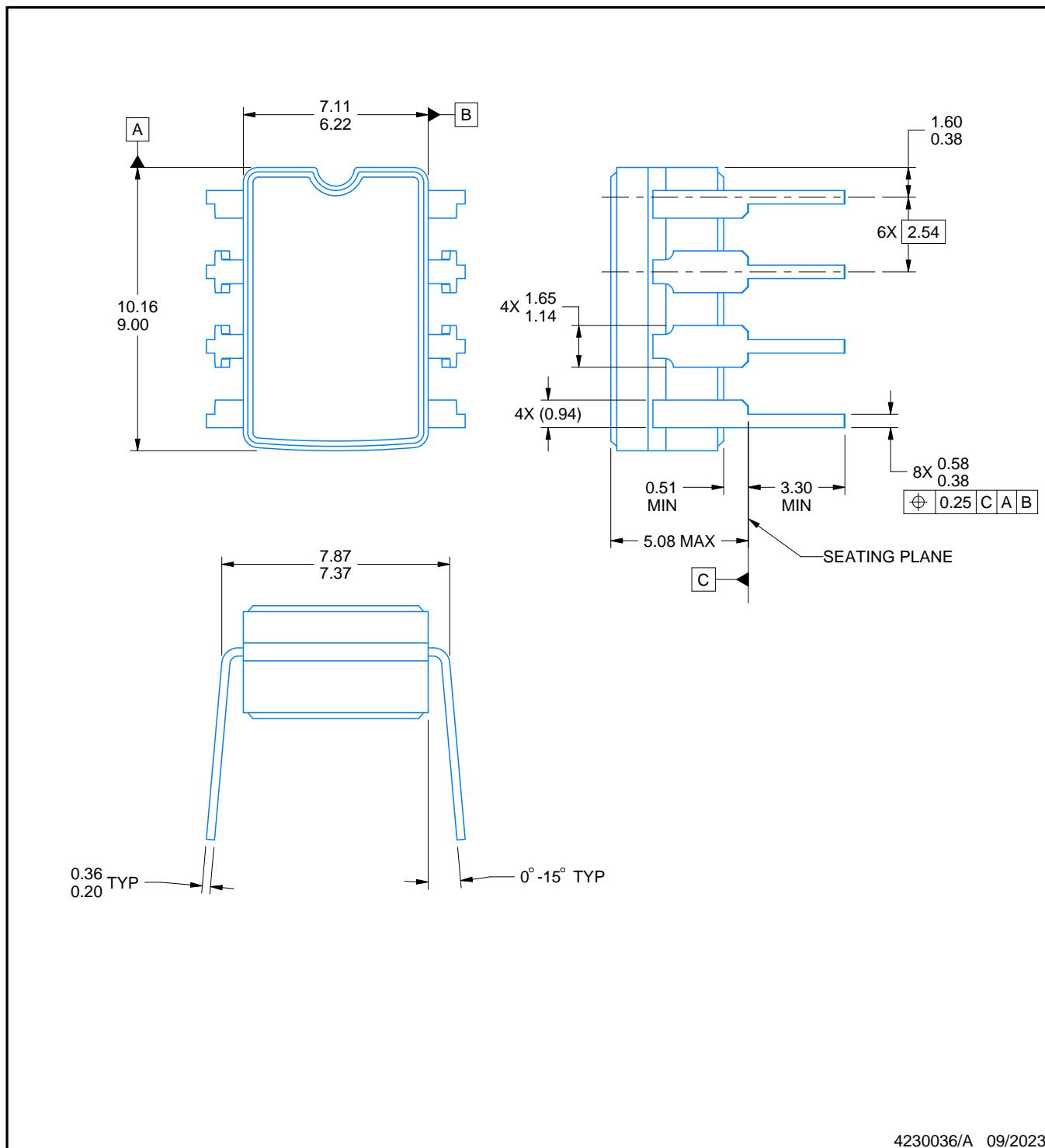
4229370VA\

# PACKAGE OUTLINE

JG0008A

CDIP - 5.08 mm max height

CERAMIC DUAL IN-LINE PACKAGE



4230036/A 09/2023

NOTES:

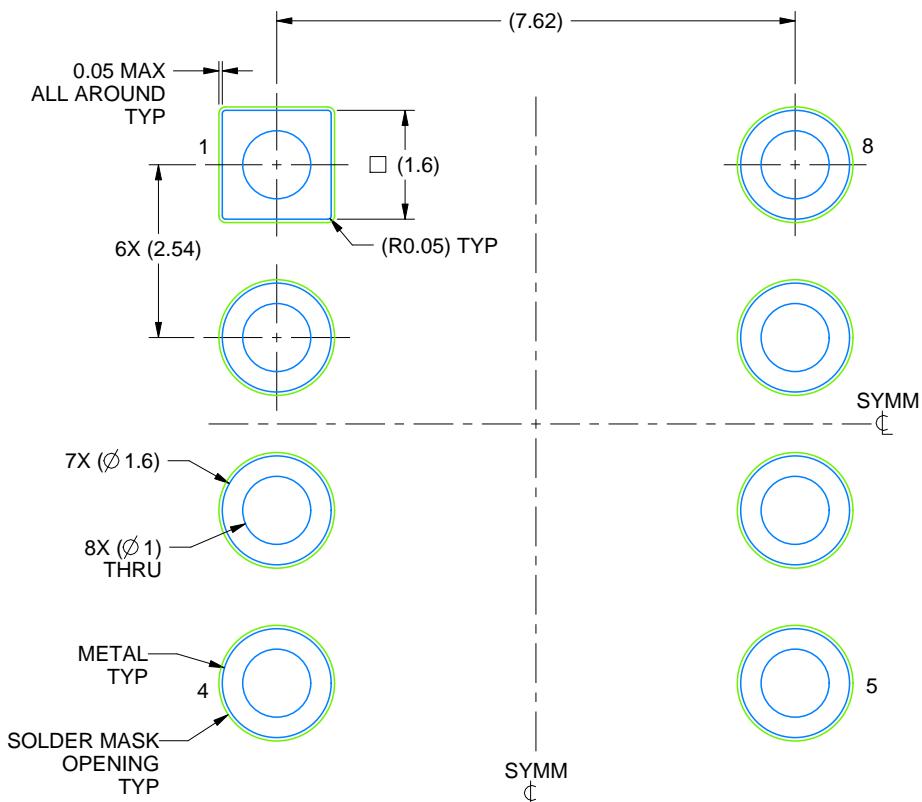
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This package can be hermetically sealed with a ceramic lid using glass frit.
4. Index point is provided on cap for terminal identification.
5. Falls within MIL STD 1835 GDIP1-T8

# EXAMPLE BOARD LAYOUT

JG0008A

CDIP - 5.08 mm max height

CERAMIC DUAL IN-LINE PACKAGE



LAND PATTERN EXAMPLE  
NON SOLDER MASK DEFINED  
SCALE: 9X

4230036/A 09/2023

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